

Sheet 1 of 3Form PTO-1449
(Rev. 2-88)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
510553.92217SERIAL NO.
09/755,337INFORMATION DISCLOSURE STATEMENT
BY APPLICANTAPPLICANT
Yu-Lin ChenFILING DATE
January 5, 2001

GROUP

(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

* EXAMINER'S INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
cl	6,117,594	09/12/00	Taylor, et al.	429	245	
cl	6,057,059	05/02/00	Kwok, et al.	429	235	
cl	6,037,081	03/14/00	Kashio, et al.	429	242	
cl	5,858,575	01/12/99	Chen	429	245	
cl	5,643,696	07/01/97	Rowlette	429	210	
cl	5,611,128	03/18/97	Wirtz	29	2	
cl	5,543,250	08/06/96	Yanagihara, et al.	429	241	
cl	5,462,109	10/31/95	Vincze, et al.	164	479	
cl	5,344,727	09/06/94	Meadows, et al.	429	210	
cl	5,024,908	06/18/91	Terada, et al.	429	245	
cl	4,939,051	07/03/90	Yasuda, et al.	429	245	
cl	4,906,540	03/06/90	Hoshihara, et al.	429	242	
cl	4,865,933	09/12/89	Blanyer, et al.	429	241	

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

cl		English Abstract for Japanese Patent Publication No. 11-054115, Published 2-26-1999
cl		English Abstract for Japanese Patent Publication No. 10-284085, Published 10-23-1998

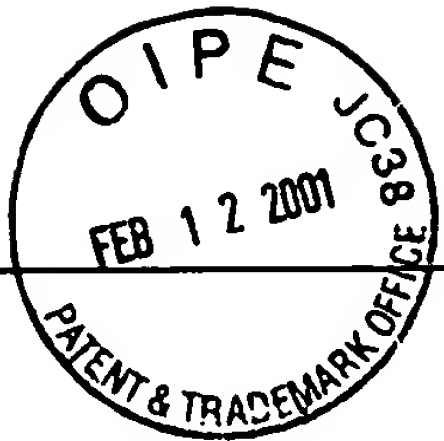
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Chen/Chen

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cl	4,865,928	09/12/89	Richter	429	120	
cl	4,805,277	02/21/89	Yasuda, et al.	29	2	
cl	4,782,585	11/08/88	Kobayashi, et al.	29	623.5	
cl	4,761,356	08/02/88	Kobayashi, et al.	429	242	
cl	4,606,383	08/19/86	Yanik	141	32	
cl	4,498,519	01/12/85	Watanabe, et al.	164	417	
cl	4,460,666	07/17/84	Dinkler, et al.	429	236	
cl	4,386,987	06/07/83	Covitch, et al.	156	155	
cl	3,349,067	09/14/82	Wirtz, et al.	164	479	
cl	4,315,356	02/16/82	Laurie, et al.	29	6.1	
cl	4,297,866	11/03/81	Sakauye, et al.	72	186	
cl	4,291,443	09/29/81	Laurie, et al.	29	6.1	
cl	4,140,840	02/20/79	Ruben	429	190	

FOREIGN PATENT DOCUMENTS

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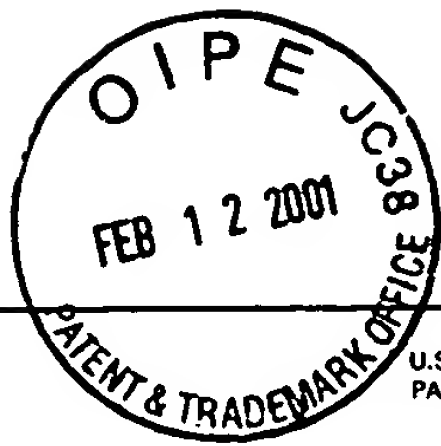
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Cawt Chen

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CL	4,107,407	8/15/78	Koch	429	226	
a	4,097,625	06/27/78	Lunn, et al.	427	360	
a	3,959,016	05/25/76	Tsuda	136	67	
a	3,933,524	01/20/76	Hughel, et al.	136	64	
ce	3,926,247	12/16/75	Geiger, et al.	164	263	
a	2,282,760	05/12/42	A. P. Haul	136	64	
a	2,193,782	03/12/40	E. W. Smith	136	64	
a	1,500,219	07/08/24	R. C. Benner			

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

Carol Chaney

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